



**AO4614A**

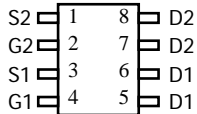
**Complementary Enhancement Mode Field Effect Transistor**

**General Description**

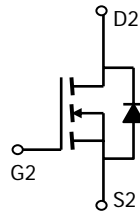
The AO4614A uses advanced trench technology MOSFETs to provide excellent  $R_{DS(ON)}$  and low gate charge. The complementary MOSFETs may be used in H-bridge, Inverters and other applications. *Standard Product AO4614A is Pb-free (meets ROHS & Sony 259 specifications).*

**Features**

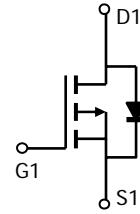
|                             |                                |
|-----------------------------|--------------------------------|
| n-channel                   | p-channel                      |
| $V_{DS} (V) = 40V$          | -40V                           |
| $I_D = 6A (V_{GS}=10V)$     | -5A ( $V_{GS} = -10V$ )        |
| $R_{DS(ON)}$                | $R_{DS(ON)}$                   |
| $< 31m\Omega (V_{GS}=10V)$  | $< 45m\Omega (V_{GS} = -10V)$  |
| $< 45m\Omega (V_{GS}=4.5V)$ | $< 63m\Omega (V_{GS} = -4.5V)$ |



**SOIC-8**



**n-channel**



**p-channel**

**Absolute Maximum Ratings  $T_A=25^\circ C$  unless otherwise noted**

| Parameter                              | Symbol         | Max n-channel    | Max p-channel | Units      |
|--|----------------|------------------|---------------|------------|
| Drain-Source Voltage                   | $V_{DS}$       | 40               | -40           | V          |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 20$         | $\pm 20$      | V          |
| Continuous Drain Current <sup>A</sup>  | $I_D$          | $T_A=25^\circ C$ | 6             | -5         |
|  |                | $T_A=70^\circ C$ | 5             | -4         |
| Pulsed Drain Current <sup>B</sup>      | $I_{DM}$       | 20               | -20           | A          |
| Power Dissipation                      | $P_D$          | $T_A=25^\circ C$ | 2             | 2          |
|  |                | $T_A=70^\circ C$ | 1.28          | 1.28       |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150       | -55 to 150    | $^\circ C$ |

**Thermal Characteristics: n-channel and p-channel**

| Parameter                                | Symbol          | Device | Typ | Max  | Units        |
|--|-----------------|--------|-----|------|--------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | n-ch   | 48  | 62.5 | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | n-ch   | 74  | 110  | $^\circ C/W$ |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | n-ch   | 35  | 50   | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | p-ch   | 48  | 62.5 | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | p-ch   | 74  | 110  | $^\circ C/W$ |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | p-ch   | 35  | 50   | $^\circ C/W$ |

N Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions  | Min | Typ  | Max       | Units         |
|-----------------------------|---------------------------------------|---|-----|------|-----------|---------------|
| <b>STATIC PARAMETERS</b>    |                                       |   |     |      |           |               |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=10\text{mA}, V_{GS}=0\text{V}$   | 40  |      |           | V             |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=32\text{V}, V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$             |     |      | 1         | $\mu\text{A}$ |
|                             |                                       |   |     |      | 5         |               |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$                                   |     |      | $\pm 100$ | nA            |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$   | 1   | 2.3  | 3         | V             |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=10\text{V}, V_{DS}=5\text{V}$                                       | 20  |      |           | A             |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}, I_D=6\text{A}$<br>$T_J=125^\circ\text{C}$               |     | 23.2 | 31        | m $\Omega$    |
|                             |                                       |   |     | 36   | 48        |               |
|                             |                                       | $V_{GS}=4.5\text{V}, I_D=5\text{A}$   |     | 32.6 | 45        | m $\Omega$    |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}, I_D=6\text{A}$   |     | 22   |           | S             |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}, V_{GS}=0\text{V}$   |     | 0.77 | 1         | V             |
| $I_S$                       | Maximum Body-Diode Continuous Current |   |     |      | 2.5       | A             |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |     |      |           |               |
| $C_{ISS}$                   | Input Capacitance                     | $V_{GS}=0\text{V}, V_{DS}=20\text{V}, f=1\text{MHz}$                        |     | 404  |           | pF            |
| $C_{OSS}$                   | Output Capacitance                    |   |     | 95   |           | pF            |
| $C_{RSS}$                   | Reverse Transfer Capacitance          |   |     | 37   |           | pF            |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$                         |     | 2.7  |           | $\Omega$      |
| <b>SWITCHING PARAMETERS</b> |                                       |   |     |      |           |               |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}, V_{DS}=20\text{V}, I_D=6\text{A}$                       |     | 8.3  |           | nC            |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |   |     | 4.2  |           | nC            |
| $Q_{gs}$                    | Gate Source Charge                    |   |     | 1.3  |           | nC            |
| $Q_{gd}$                    | Gate Drain Charge                     |   |     | 2.3  |           | nC            |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}, V_{DS}=20\text{V}, R_L=3.3\Omega,$<br>$R_{GEN}=3\Omega$ |     | 4.2  |           | ns            |
| $t_r$                       | Turn-On Rise Time                     |   |     | 3.3  |           | ns            |
| $t_{D(off)}$                | Turn-Off DelayTime                    |   |     | 15.6 |           | ns            |
| $t_f$                       | Turn-Off Fall Time                    |   |     | 3    |           | ns            |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=6\text{A}, dI/dt=100\text{A}/\mu\text{s}$                              |     | 20.5 |           | ns            |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=6\text{A}, dI/dt=100\text{A}/\mu\text{s}$                              |     | 14.5 |           | nC            |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $t_s \leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

Rev 1: Sept 2006

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P-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions   | Min | Typ   | Max       | Units         |
|-----------------------------|---------------------------------------|--|-----|-------|-----------|---------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |       |           |               |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=-10\text{mA}$ , $V_{GS}=0\text{V}$  | -40 |       |           | V             |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=-32\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                |     |       | -1        | $\mu\text{A}$ |
|                             |                                       |  |     |       | -5        |               |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$                                       |     |       | $\pm 100$ | nA            |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=-250\mu\text{A}$  | -1  | -1.9  | -3        | V             |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=-10\text{V}$ , $V_{DS}=-5\text{V}$   | -20 |       |           | A             |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=-10\text{V}$ , $I_D=-5\text{A}$<br>$T_J=125^\circ\text{C}$                 |     | 32.5  | 45        | m $\Omega$    |
|                             |                                       |  |     | 52    | 65        |               |
|                             |                                       | $V_{GS}=-4.5\text{V}$ , $I_D=-2\text{A}$   |     | 51.4  | 63        | m $\Omega$    |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=-5\text{V}$ , $I_D=-4.8\text{A}$   |     | 12    |           | S             |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=-1\text{A}$ , $V_{GS}=0\text{V}$  |     | -0.75 | -1        | V             |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |     |       | -2.5      | A             |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |       |           |               |
| $C_{ISS}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=-20\text{V}$ , $f=1\text{MHz}$                        |     | 657   |           | pF            |
| $C_{OSS}$                   | Output Capacitance                    |  |     | 143   |           | pF            |
| $C_{RSS}$                   | Reverse Transfer Capacitance          |  |     | 63    |           | pF            |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                          |     | 6.5   |           | $\Omega$      |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |       |           |               |
| $Q_g(10\text{V})$           | Total Gate Charge (10V)               | $V_{GS}=-10\text{V}$ , $V_{DS}=-20\text{V}$ , $I_D=-5\text{A}$                     |     | 13.6  |           | nC            |
| $Q_g(4.5\text{V})$          | Total Gate Charge (4.5V)              |  |     | 6.8   |           | nC            |
| $Q_{gs}$                    | Gate Source Charge                    |  |     | 1.8   |           | nC            |
| $Q_{gd}$                    | Gate Drain Charge                     |  |     | 3.9   |           | nC            |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=-10\text{V}$ , $V_{DS}=-20\text{V}$ , $R_L=4\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 7.5   |           | ns            |
| $t_r$                       | Turn-On Rise Time                     |  |     | 6.7   |           | ns            |
| $t_{D(off)}$                | Turn-Off DelayTime                    |  |     | 26    |           | ns            |
| $t_f$                       | Turn-Off Fall Time                    |  |     | 11.2  |           | ns            |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=-5\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                 |     | 22.3  |           | ns            |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=-5\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                 |     | 15.2  |           | nC            |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $t \leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

Rev 0 : Jan 2007

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CHANNEL

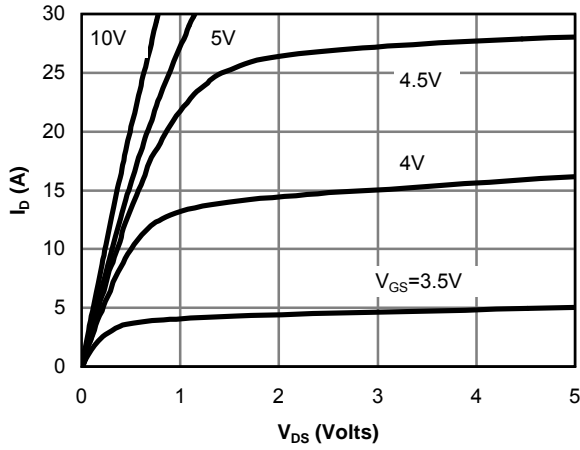


Figure 1: On-Region Characteristics

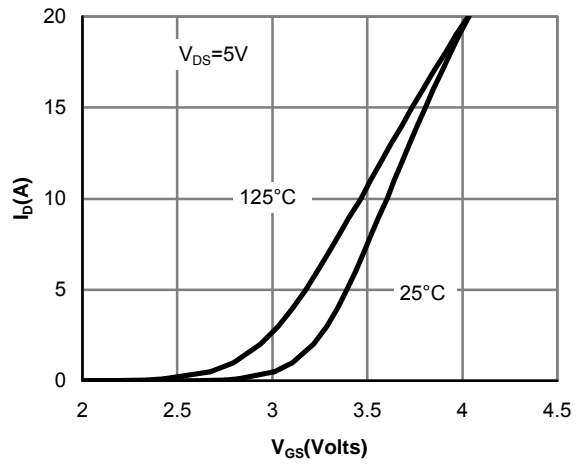


Figure 2: Transfer Characteristics

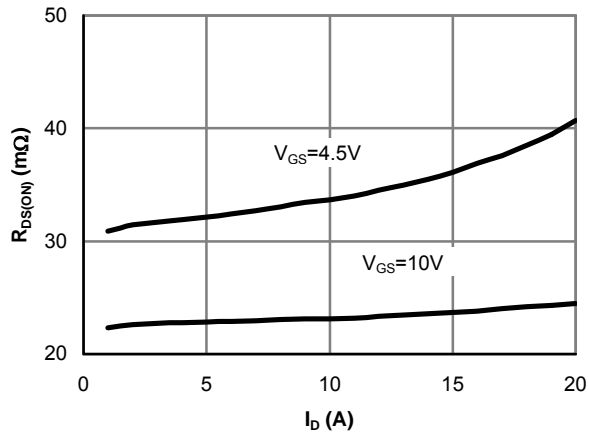


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

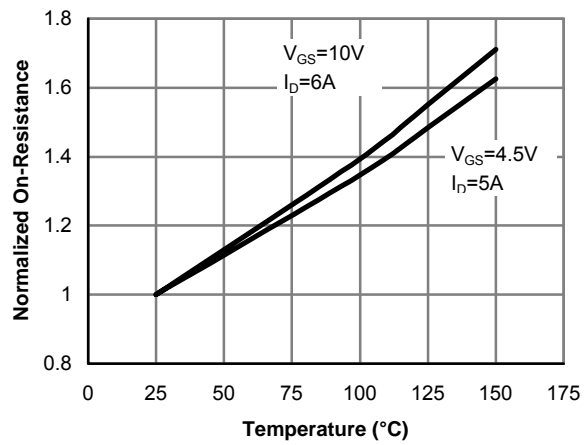


Figure 4: On-Resistance vs. Junction Temperature

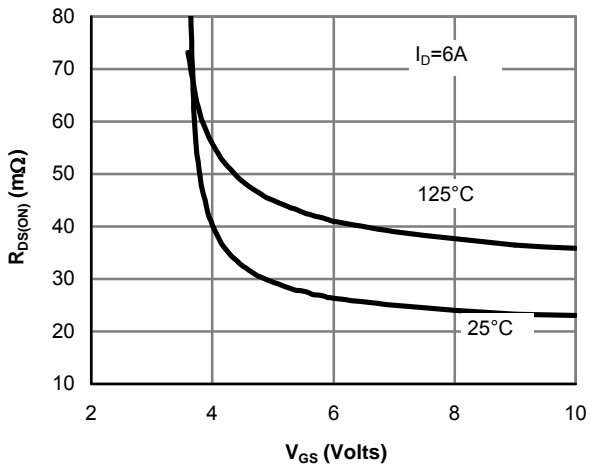


Figure 5: On-Resistance vs. Gate-Source Voltage

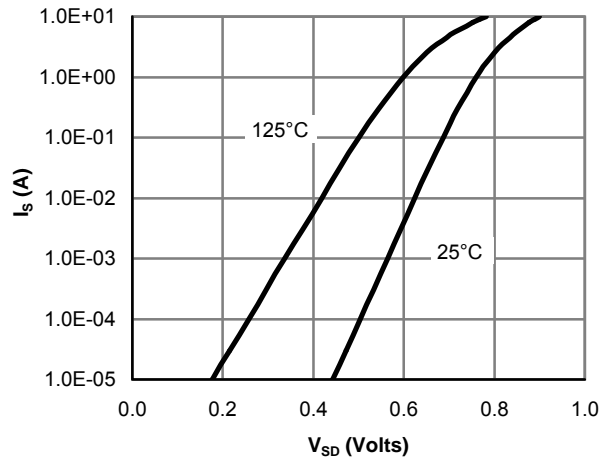


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CHANNEL

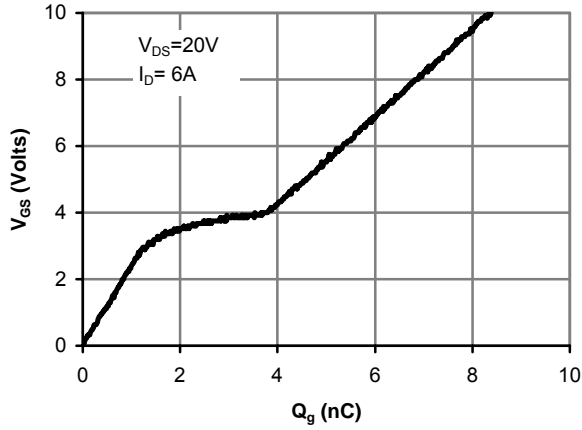


Figure 7: Gate-Charge Characteristics

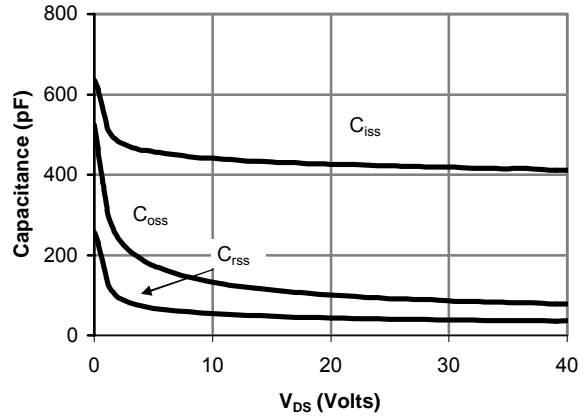


Figure 8: Capacitance Characteristics

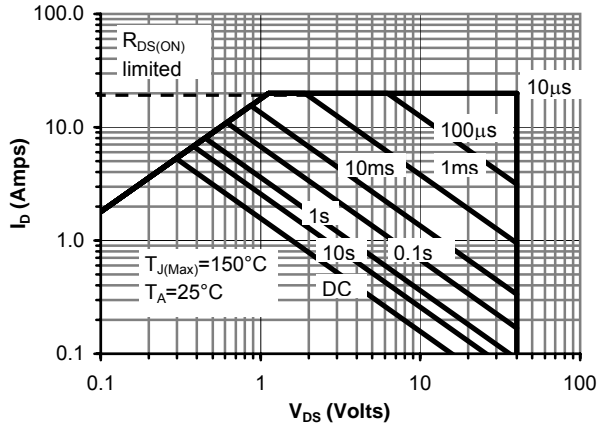


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

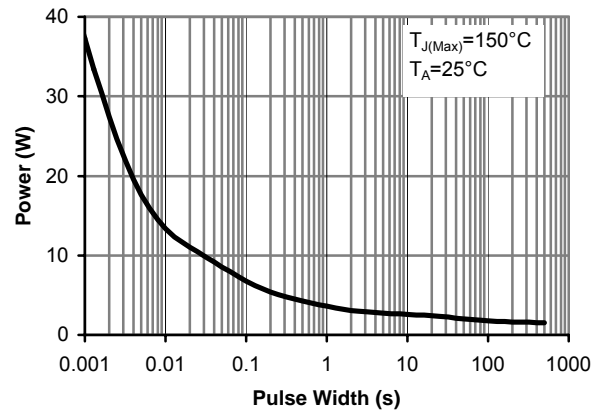


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

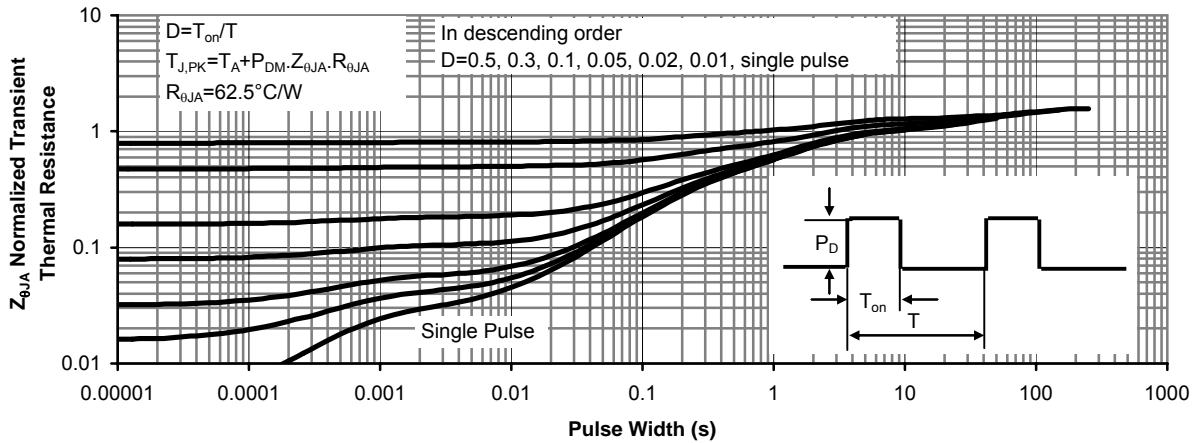


Figure 11: Normalized Maximum Transient Thermal Impedance

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

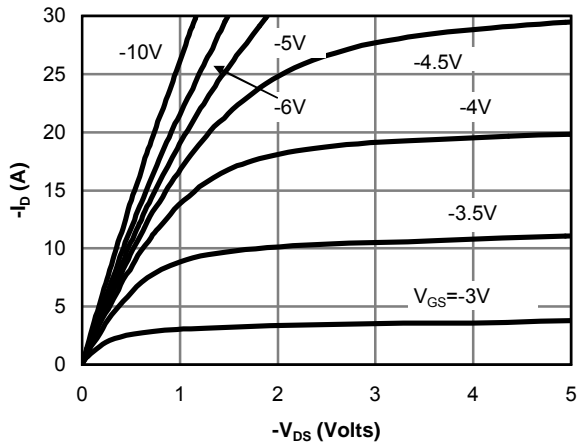


Figure 1: On-Region Characteristics

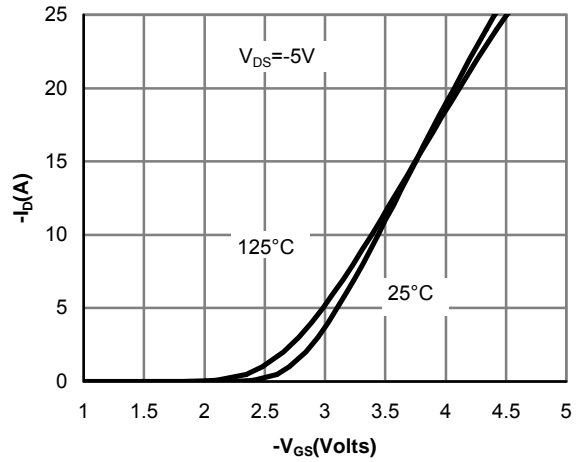


Figure 2: Transfer Characteristics

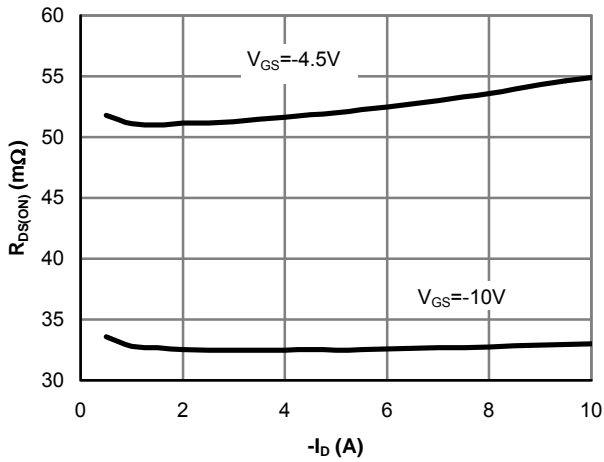


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

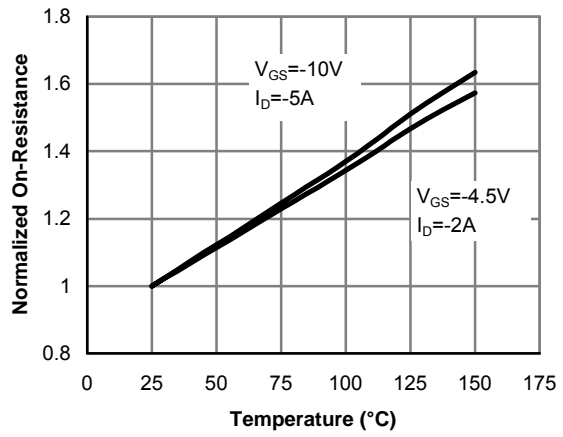


Figure 4: On-Resistance vs. Junction Temperature

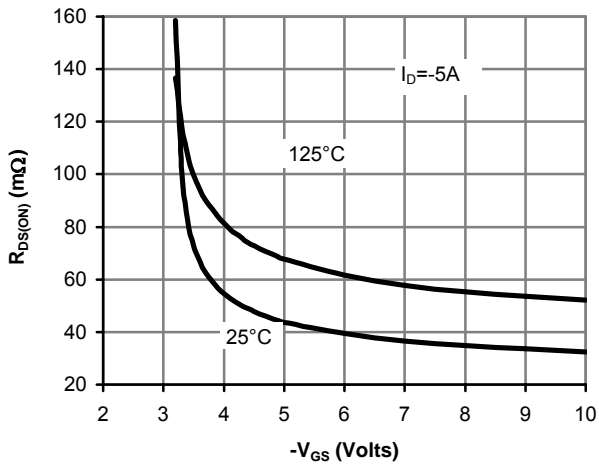


Figure 5: On-Resistance vs. Gate-Source Voltage

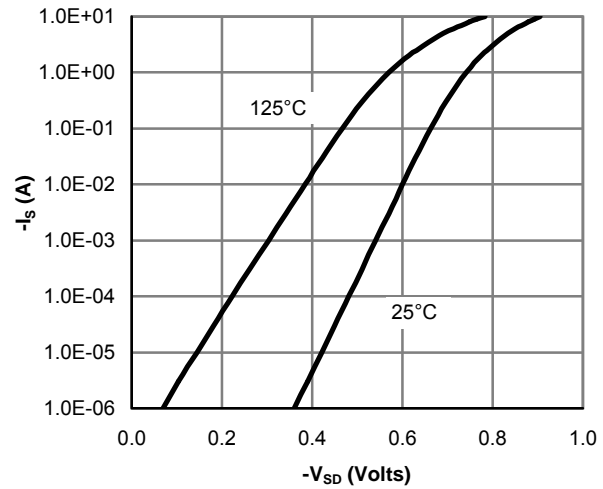


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

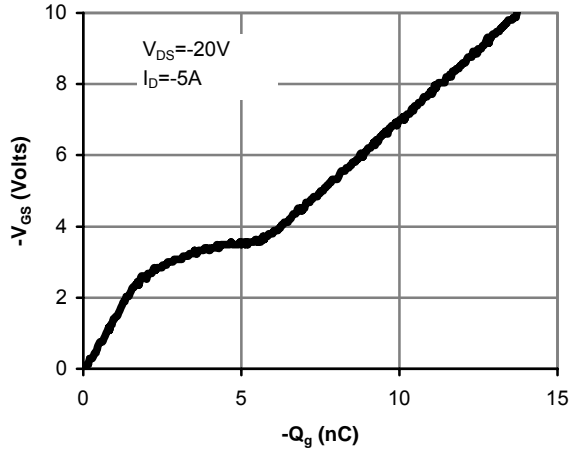


Figure 7: Gate-Charge Characteristics

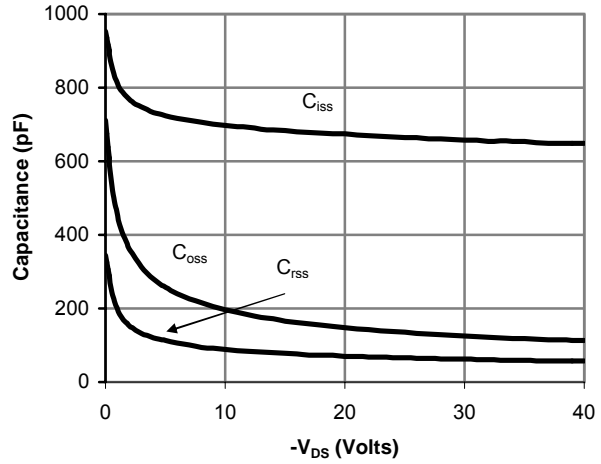


Figure 8: Capacitance Characteristics

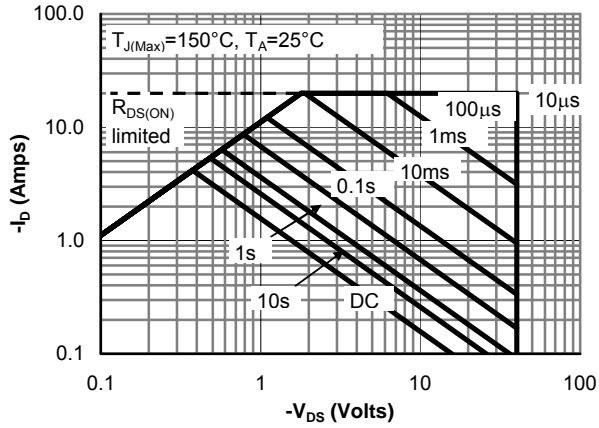


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

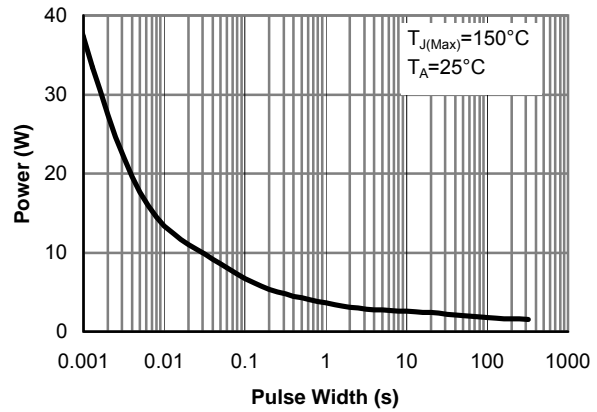


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

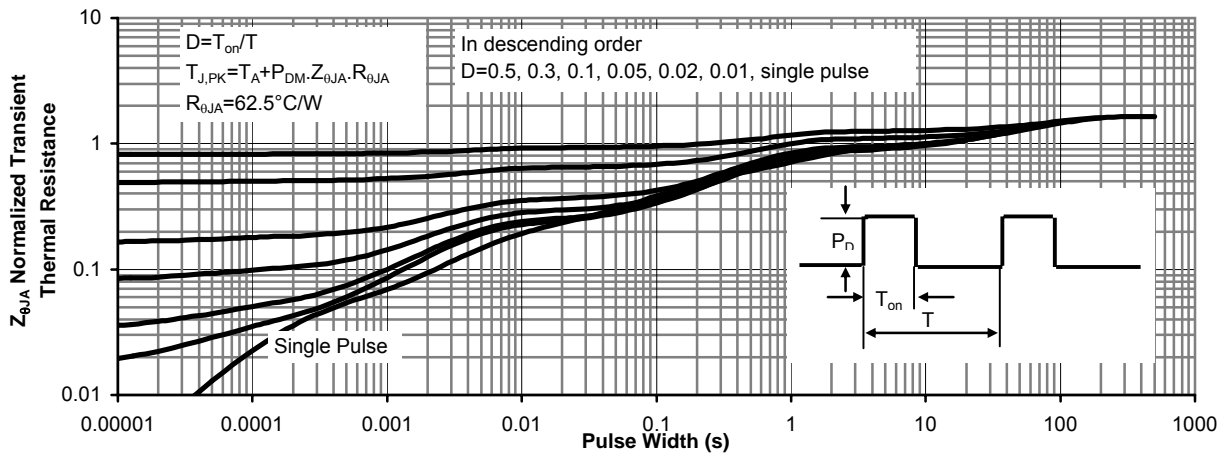


Figure 11: Normalized Maximum Transient Thermal Impedance